Semiconductor Device Test Set - Page 1 of 1



View Online at https://aerobasegroup.com/nsn/6625-00-528-6768

Inclosure Feature:

Single item w/housing

Test Type For Which Designed:

Transistor tester

Phase:

Single

Special Features:

Go/no go test in or out of circuit; connect test leads in any order; rotating switch; order probe separately for testing pc boards

Shelf Life:

N/a

Unit Of Measure:

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Demilitarization:

No

Fiig:

T228-a